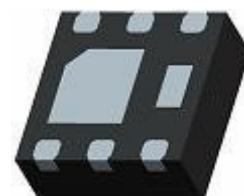


## **WPM1481**

**Single P-Channel, -12V, -5.5A, Power MOSFET**

[Http://www.sh-willsemi.com](http://www.sh-willsemi.com)

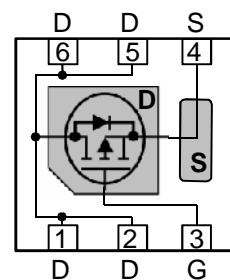
<b>V<sub>DS</sub> (V)</b>	<b>Typical R<sub>ds(on)</sub> ( )</b>	<b>I<sub>D</sub> (A)</b>
<b>-12</b>	0.022@ V <sub>GS</sub> = -4.5V	-5.5
	0.030@ V <sub>GS</sub> = -2.5V	-4.0
	0.045@ V <sub>GS</sub> = -1.8V	-2.5



DFN2\*2-6L

## **Descriptions**

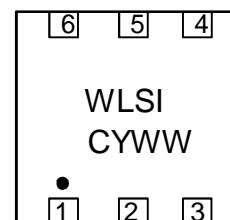
The WPM1481 is P-Channel enhancement MOS Field Effect Transistor. Uses advanced trench technology and design to provide excellent R<sub>DS (ON)</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit. Standard Product WPM1481 is Pb-free.



Pin configuration (Top view)

## **Features**

- Trench Technology
- Supper high density cell design
- Excellent ON resistance for higher DC current
- Extremely Low Threshold Voltage
- Small package DFN2\*2-6L



WLSI = Company Code  
 C = Device Code  
 Y = Year  
 WW = Week

## **Applications**

## **Marking**

## **Order information**

- Driver for Relay, Solenoid, Motor, LED etc.
- DC-DC converter circuit
- Power Switch
- Load Switch
- Charging

<b>Device</b>	<b>Package</b>	<b>Shipping</b>
WPM1481- 6/TR	DFN2*2-6L	3000/Reel&Tape

## Absolute Maximum ratings

Parameter	Symbol	10 S	Steady State	Unit
Drain-Source Voltage	V <sub>DS</sub>	-12	V	
Gate-Source Voltage	V <sub>GS</sub>	±12		
Continuous Drain Current <sup>a d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	-5.1	A
	T <sub>A</sub> =70°C		-4.0	
Maximum Power Dissipation <sup>a d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	1.9	W
	T <sub>A</sub> =70°C		1.2	
Continuous Drain Current <sup>b d</sup>	T <sub>A</sub> =25°C	I <sub>D</sub>	-3.7	A
	T <sub>A</sub> =70°C		-3.0	
Maximum Power Dissipation <sup>b d</sup>	T <sub>A</sub> =25°C	P <sub>D</sub>	1.0	W
	T <sub>A</sub> =70°C		0.6	
Pulsed Drain Current <sup>c</sup>	I <sub>DM</sub>		-24	A
Operating Junction Temperature	T <sub>J</sub>		-55~150	°C
Lead Temperature	T <sub>L</sub>		260	°C
Storage Temperature Range	T <sub>stg</sub>		-55 ~150	°C

## Thermal resistance ratings

Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient Thermal Resistance <sup>a</sup>	t = 10 s	R <sub>JA</sub>	49	°C/W
	Steady State		66	
Junction-to-Ambient Thermal Resistance <sup>b</sup>	t = 10 s	R <sub>JA</sub>	84	°C/W
	Steady State		125	
Junction-to-Case Thermal Resistance	R <sub>JC</sub>	32	42	

a Surface mounted on FR-4 Board using 1 square inch pad size, 1oz copper

b Surface mounted on FR-4 board using minimum pad size, 1oz copper

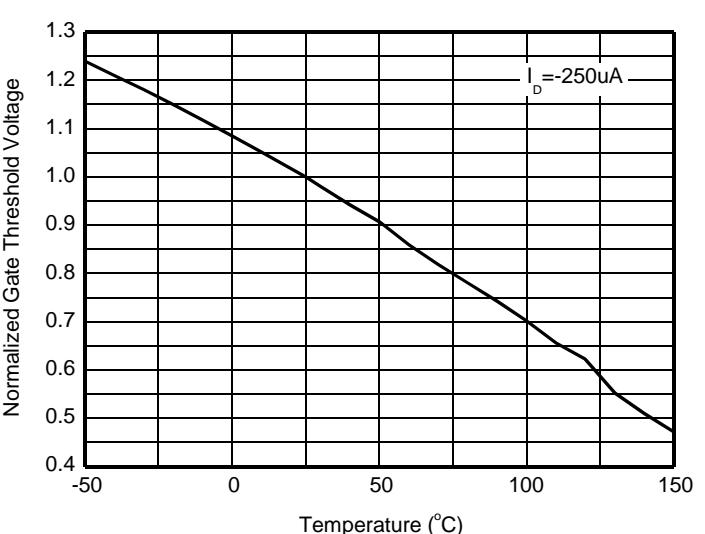
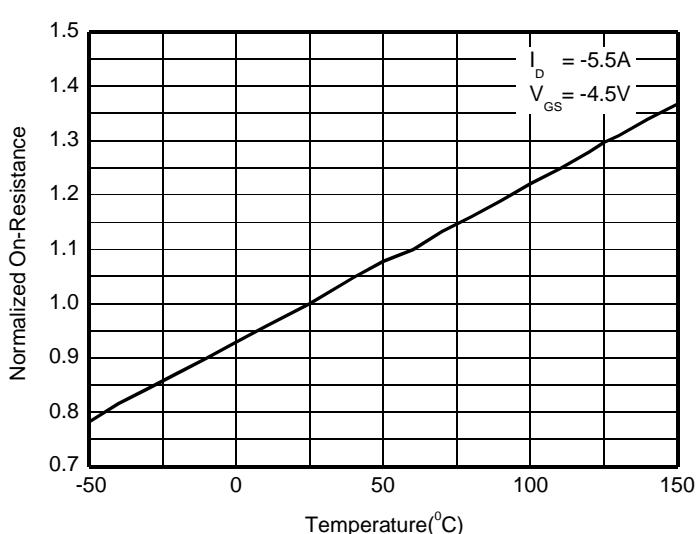
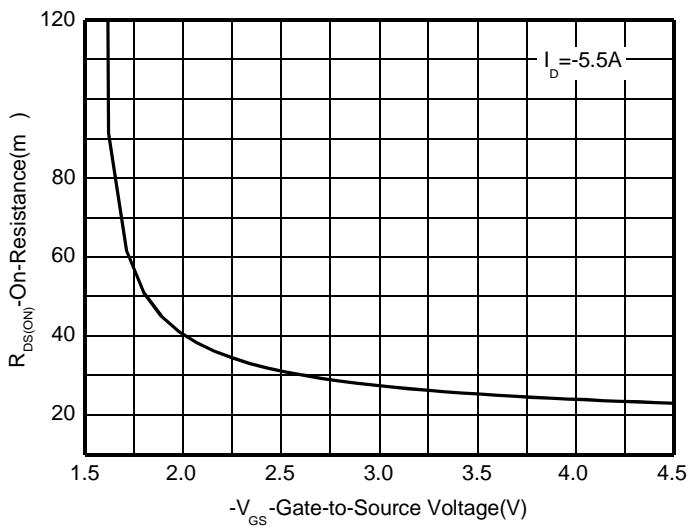
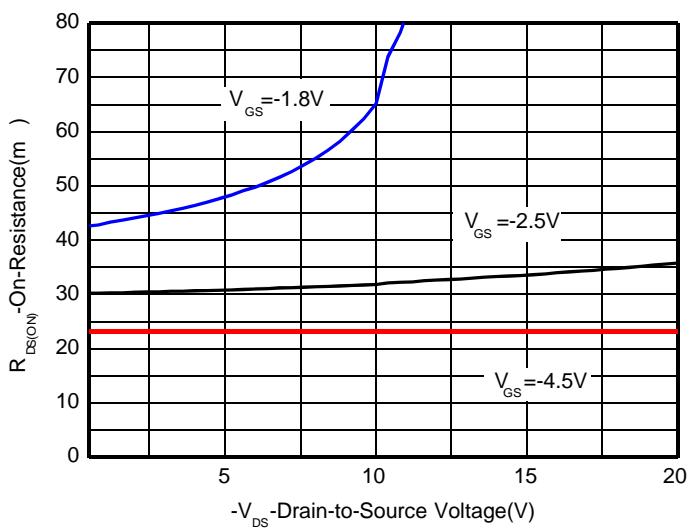
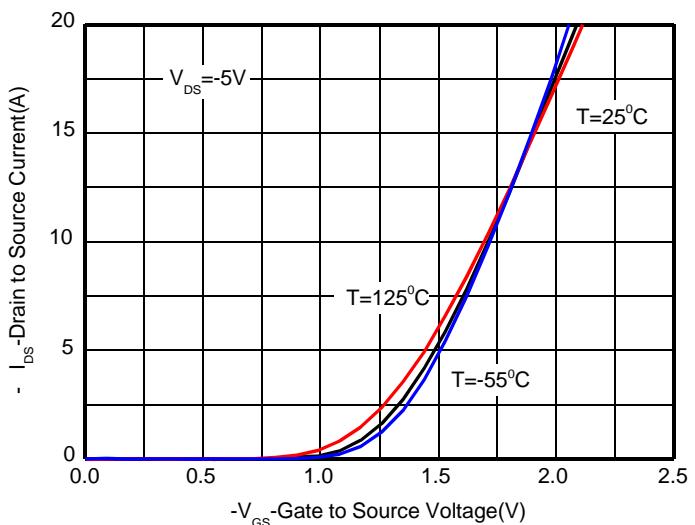
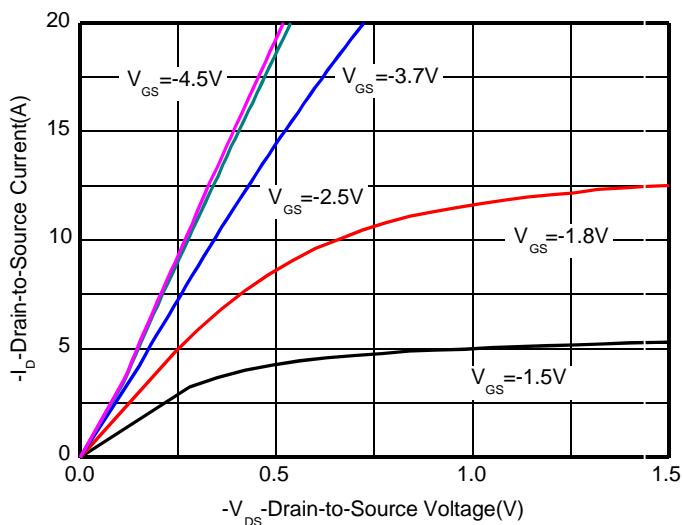
c Pulse width<380μs, Single pulse

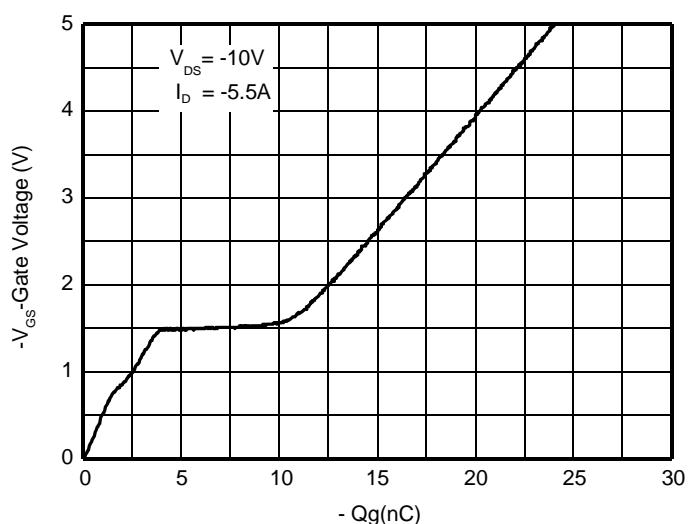
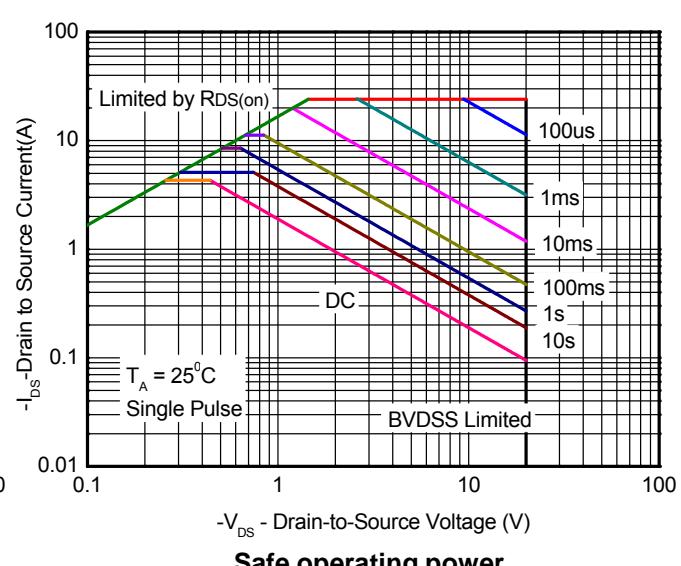
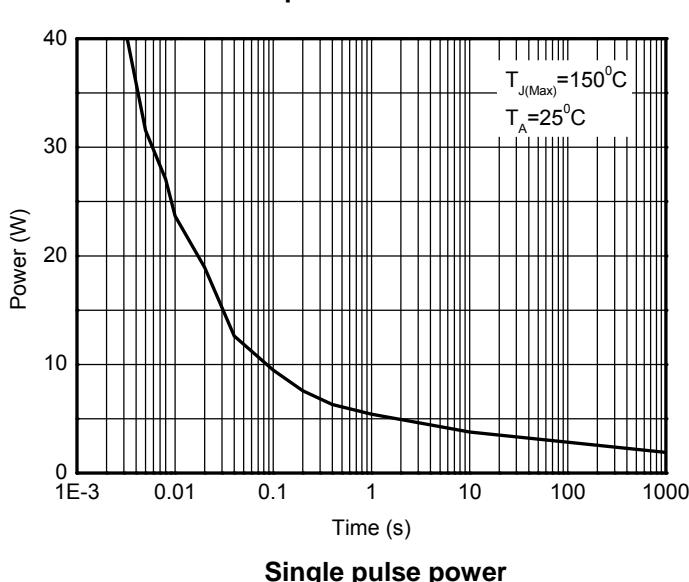
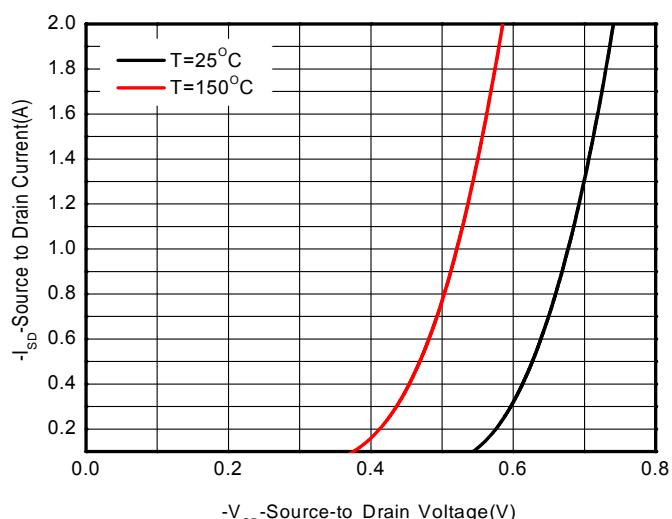
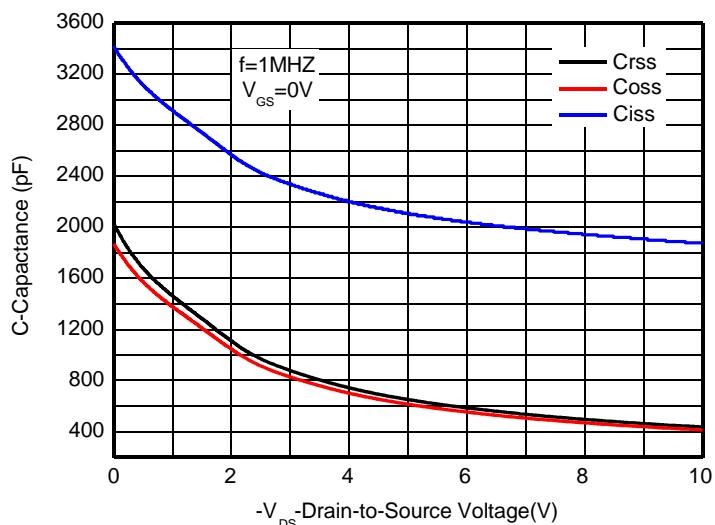
d Maximum junction temperature T<sub>J</sub>=150°C.

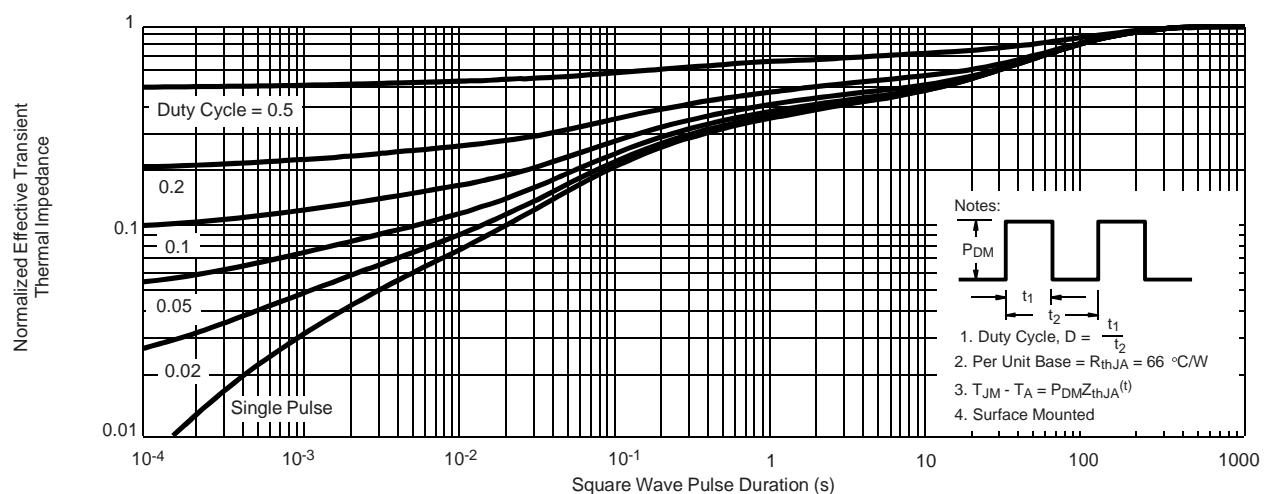
e Pulse test: Pulse width <380 us duty cycle <2%.

**Electronics Characteristics (Ta=25°C, unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-to-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250uA	-12			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V			-1	uA
Gate-to-source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =±10V			±100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250uA	-0.4		-0.9	V
Drain-to-source On-resistance <sup>b, e</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -5.5A		22	26	m
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -4.0A		30	38	
		V <sub>GS</sub> = -1.8V, I <sub>D</sub> = -2.5A		45	59	
Forward Transconductance <sup>e</sup>	g <sub>FS</sub>	V <sub>DS</sub> = -5.0V, I <sub>D</sub> = -5.5A		23		S
<b>CAPACITANCES, CHARGES</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -10 V		1880		pF
Output Capacitance	C <sub>OSS</sub>			437		
Reverse Transfer Capacitance	C <sub>RSS</sub>			413		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -10 V, I <sub>D</sub> = -5.5A		44.5		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			3.5		
Gate-to-Source Charge	Q <sub>GS</sub>			1.7		
Gate-to-Drain Charge	Q <sub>GD</sub>			9.25		
<b>SWITCHING CHARACTERISTICS</b>						
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DS</sub> = -6 V, R <sub>L</sub> =3 , R <sub>G</sub> =6		33.6		ns
Rise Time	t <sub>r</sub>			35.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>			50		
Fall Time	t <sub>f</sub>			63		
<b>BODY DIODE CHARACTERISTICS</b>						
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>s</sub> = 1.0A		-0.76	-1.5	V

**Typical Characteristics (Ta=25°C, unless otherwise noted)**


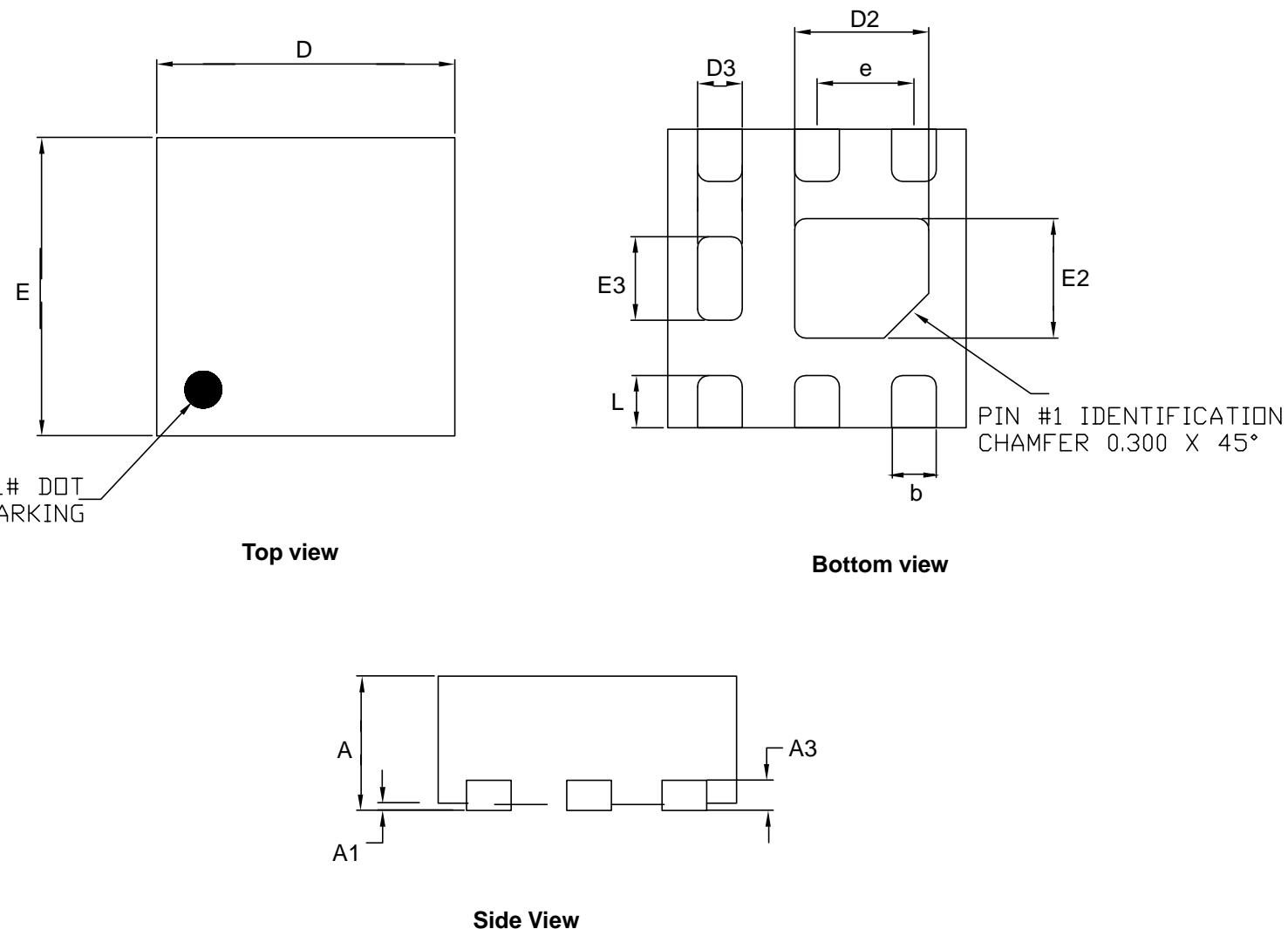




**Transient thermal response (Junction-to-Ambient)**

### Package outline dimensions

DFN2\*2-6L



Symbol	Dimensions in millimeter		
	Min.	Typ.	Max.
A	0.70	0.75	0.80
A1	0.00	-	0.05
A3	0.203 Ref.		
D	1.95	2.00	2.05
E	1.95	2.00	2.05
D2	0.85	0.90	0.95
E2	0.75	0.80	0.85
D3	0.25	0.30	0.35
E3	0.51	0.56	0.61
b	0.25	0.30	0.35
L	0.30	0.35	0.40
e	0.65 BSC.		